

# BT138Y series E

# 12 A four-quadrant triacs, sensitive gate, insulated Rev. 01 — 3 June 2008 Produ

**Product data sheet** 

### **Product profile**

### 1.1 General description

Passivated sensitive gate triac in an internally insulated TO-220 plastic package.

### 1.2 Features

- Isolated mounting base
- Sensitive gate
- Direct interfacing to logic level ICs
- 2500 V RMS isolation voltage
- Gate triggering in four quadrants
- Direct interfacing to low-power gate drive circuits

### 1.3 Applications

- General-purpose switching and phase control
- 230 V lamp dimmers

#### 1.4 Quick reference data

- $I_{T(RMS)} \le 12 A$
- $V_{DRM} \le 600 \text{ V (BT138Y-600E)}$
- $V_{DRM} \le 800 \text{ V (BT138Y-800E)}$
- $I_{GT} \le 10 \text{ mA}$
- $I_{GT} \le 25 \text{ mA } (T2-G+)$
- $I_{TSM} \le 95 \text{ A (t = 20 ms)}$

### **Pinning information**

Table 1. **Pinning** 

Pin	Description	Simplified outline	Graphic symbol
1	main terminal 1 (T1)		отприне о <b>ј</b>
2	main terminal 2 (T2)	mb	T2-1
			K
3	gate (G)		sym051
mb	mounting base; isolated		
		1 2 3 SOT78D (TO-220)	



### 3. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BT138Y-600E	TO-220	plastic single-ended package; isolated heatsink mounted; 1 mounting hole;	SOT78D
BT138Y-800E		3-lead TO-220	

### 4. Limiting values

#### Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage				
		BT138Y-600E	<u>[1]</u> _	600	V
		BT138Y-800E	-	800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{mb} \le 85$ °C; see Figure 4 and 5	-	12	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 20 ms	-	95	Α
		t = 16.7 ms	-	105	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	$t_p = 10 \text{ ms}$	-	45	$A^2s$
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_{TM} = 20 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$			
		T2+ G+	-	50	A/μs
		T2+ G-	-	50	A/μs
		T2- G-	-	50	A/μs
		T2- G+	-	10	A/μs
I <sub>GM</sub>	peak gate current		-	2	Α
$P_{GM}$	peak gate power		-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.5	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

<sup>[1]</sup> Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15  $A/\mu s$ .

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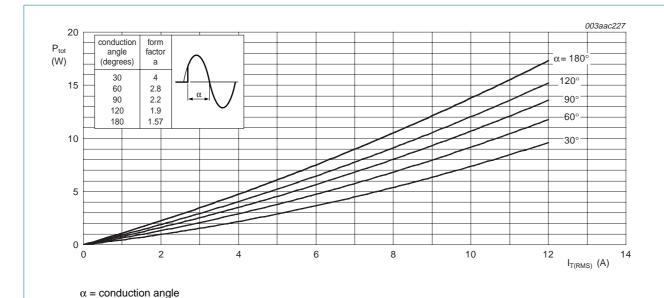
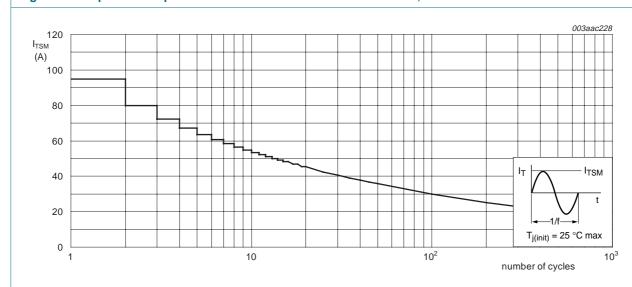
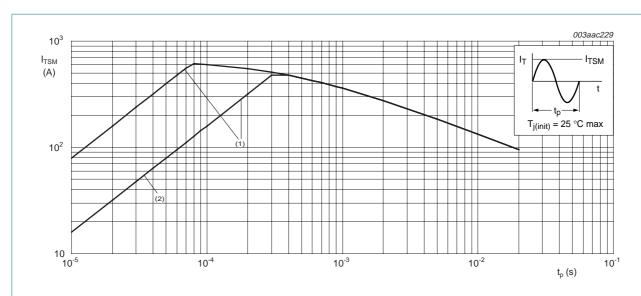


Fig 1. Total power dissipation as a function of RMS on-state current; maximum values



f = 50 Hz

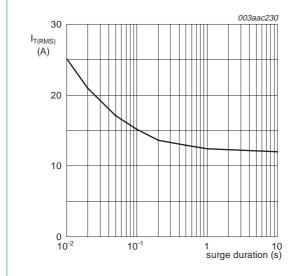
Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \le 20 \text{ ms}$ 

- (1) dl<sub>T</sub>/dt limit
- (2) T2- G+ quadrant limit

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values



f = 50 Hz

T<sub>mb</sub> = 85 °C

Fig 4. RMS on-state current as a function of surge duration; maximum values

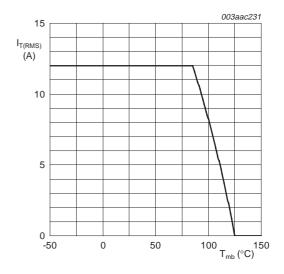
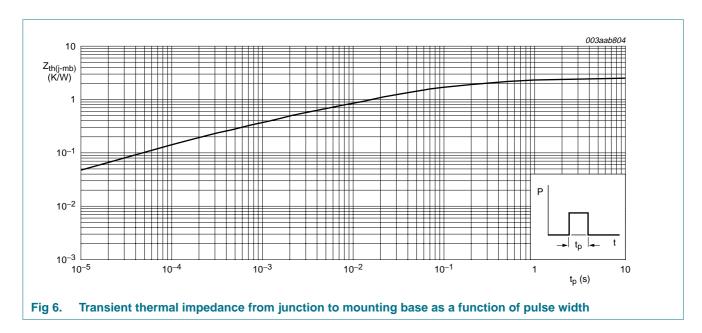


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values

### 5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	full cycle; see Figure 6	-	-	2.3	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	full cycle; in free air	-	60	-	K/W



### 6. Isolation characteristics

#### Table 5. Isolation limiting values and characteristics

 $T_h = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	from all three terminals to external heatsink; f = 50 Hz to 60 Hz; sinusoidal waveform; RH $\leq$ 65 %; clean and dust free	-	-	2500	V
C <sub>isol</sub>	isolation capacitance	from pin 2 to external heatsink; f = 1 MHz	-	10	-	pF

### 7. Static characteristics

Table 6. Static characteristics

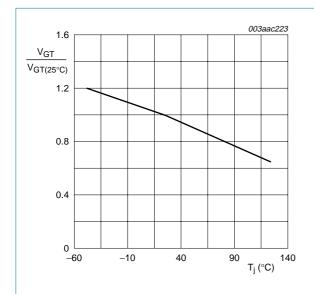
 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$I_{GT}$	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 8}}{}$				
		T2+ G+	-	-	10	mA
		T2+ G-	-	-	10	mA
		T2- G-	-	-	10	mA
		T2- G+	-	-	25	mA
IL la	latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 10}{}$				
		T2+ G+	-	-	30	mA
		T2+ G-	-	-	40	mA
		T2- G-	-	-	30	mA
		T2- G+	-	-	40	mA
I <sub>H</sub>	holding current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 11}{}$	-	-	30	mA
$V_{T}$	on-state voltage	I <sub>T</sub> = 15 A; see <u>Figure 9</u>	-	1.4	1.65	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 7}}{}$	-	0.7	1.5	V
		$V_D = V_{DRM}$ ; $I_T = 0.1 A$ ; $T_j = 125 ^{\circ}C$	0.25	0.4	-	V
I <sub>D</sub>	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-	0.1	0.5	mA
I <sub>D</sub>	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-	0.1	0.5	

### 8. Dynamic characteristics

Table 7. Dynamic characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM} = 0.67 \times V_{DRM(max)}$ ; $T_j = 125$ °C; exponential waveform; gate open circuit	-	50	-	V/μs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 16 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs



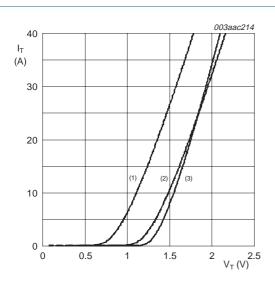
3 IGT IGT(25°C) 2 (1) (2) (3) (4) (4) (4) (1) (2) (3) (3) (4) (4) (4) (4) (7) (8) (9) (14) (17) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (19) (

- (1) T2-G+
- (2) T2-G-
- (3) T2+ G-
- (4) T2+ G+

Fig 7. Normalized gate trigger voltage as a function of junction temperature

Fig 8. Normalized gate trigger current as a function of junction temperature

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 $V_0 = 1.175 \text{ V}$ 

 $R_s = 0.032 \Omega$ 

- (1)  $T_i = 125$  °C; typical values
- (2)  $T_i = 125 \,^{\circ}C$ ; maximum values
- (3)  $T_j = 25$  °C; maximum values

Fig 9. On-state current as a function of on-state voltage

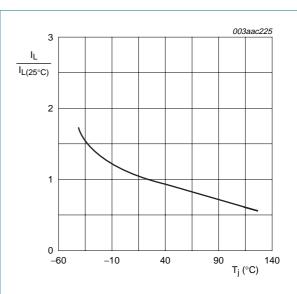


Fig 10. Normalized latching current as a function of junction temperature

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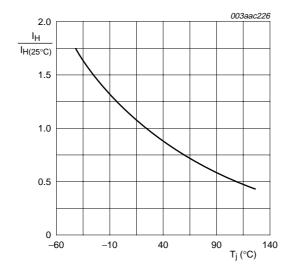


Fig 11. Normalized holding current as a function of junction temperature

### 9. Package outline

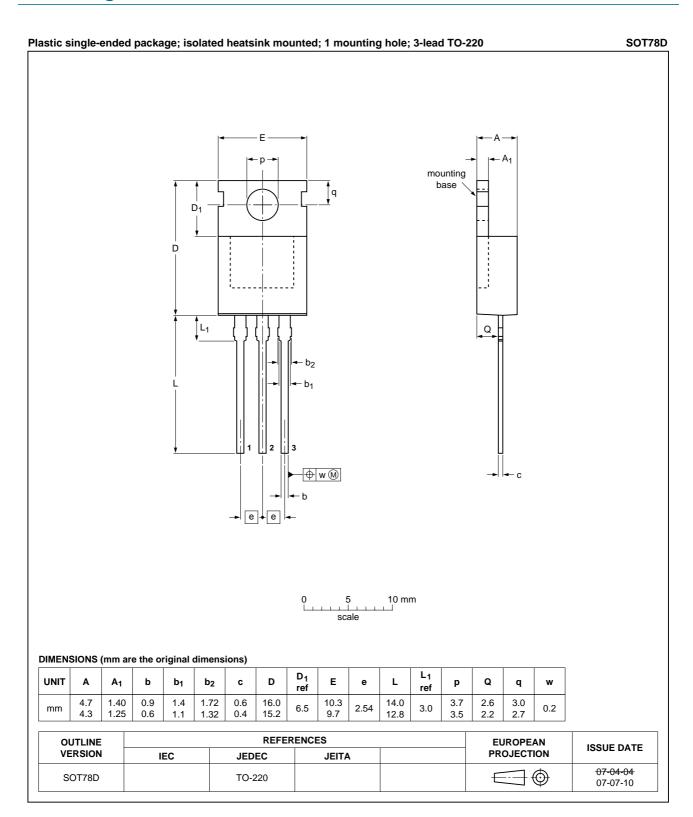


Fig 12. Package outline SOT78D (TO-220)

**BT138Y series E** 

12 A four-quadrant triacs, sensitive gate, insulated

## 10. Revision history

### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT138Y_SER_E_1	20080603	Product data sheet	-	-

### 11. Legal information

#### 11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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- [2] The term 'short data sheet' is explained in section "Definitions"
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# BT138Y series E

### 12 A four-quadrant triacs, sensitive gate, insulated

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